

Ultrahigh-Speed Hybrid **Track-and-Hold Amplifiers**

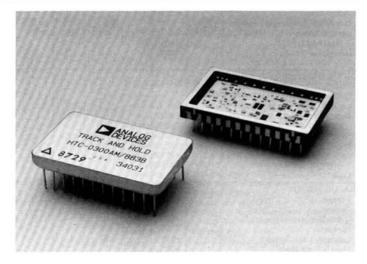
HTC-0300A

FEATURES

Aperture Jitter of 50ps Input Range ±10V Output Current ±50mA Max Droop Rate 5µV/µs Max 200ns Acquisition Time (0.01%; 10V Step)

APPLICATIONS

Data Acquisition Systems Peak Measurement Systems Simultaneous Sample & Hold Analog Delay



GENERAL DESCRIPTION

The HTC-0300A is a hybrid microcircuit track-and-hold amplifier useful in a wide range of signal processing applications, including waveform measurements, analog signal delay, and signal sampling.

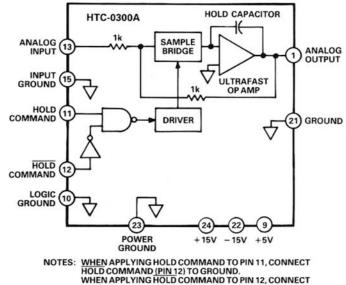
The unit has a typical aperture jitter of only 50 picoseconds rms; wide dynamic input range of ± 10 volts; and laser-trimmed gain and offset which preclude a need for external adjustments. Its speed and precision are the result of innovative design techniques using a high-speed op amp and DMOSFET switches. These techniques also enhance device performance in feedthrough rejection, linearity, harmonic distortion, droop rate, and output voltage swing.

ORDERING INFORMATION

For a case temperature range of -25° C to $+85^{\circ}$ C, order the HTC-0300A; it is packaged in a 24-pin hermetically-sealed ceramic DIP.

A military case temperature range of -55°C to + 125°C is available with the HTC-0300AM, HTC-0300AM/883B, and the HTC-0300ATD/883B. The first two units are housed in 24-pin metal packages, and the latter unit is packaged in a hermetic 24-pin ceramic DIP.

All versions of the HTC-0300A are manufactured in a facility which has been certified to MIL-STD-1772.



HOLD COMMAND (PIN 11) TO +5V

Functional Block Diagram

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SPECIFICATIONS (Typical with nominal supplies, unless otherwise noted)

	Sub-			to +85°C ITC-0300		H	to + 125°C TC-0300A 883B AM/	M		OUTLINE DIMENSIONS Dimensions shown in inches and (mm).
Parameter ^{1,2} (Conditions)		Temp.	Min	Тур	Max	Min	Тур	Max	Units	HTC-0300A and HTC-0300ATD/883B
ANALOG INPUT (FS = Full Scale = 10V; FSR = Full-Scale Range = 20V) # Voltage Range # Overvoltage, No Damage √ Input Impedance (V _{IN} = 10V; Pins 11 & 12 = "0") # Initial Offset Voltage (V _{IN} = 0V; Pins 11 & 12 = "0")	1,2,3 1	+ 25°C + 25°C Full + 25°C	950	1000 ±0.5	± 10 ± 15 1050 ± 5.0	950	1000 ±0.5	$\pm 10 \\ \pm 15 \\ 1050 \\ \pm 5.0$	V V Ω mV	1.295 ±0.015 (32.89 ±0.381) ESD SYMBOL ON TOP 0.050 (1.27) TYP AND INDEX DENOTE PIN NO. 1 + + + 0 0.160 ±0.020 (4.06 ±0.020 (4.06 ±0.020) 0.230 (5.842)
DIGITAL INPUT MODE CONTROL (TTL Compatible) / Logic "0" Input Voltage / Logic "0" Input Current # Logic "0" Input Current / Logic "1" Input Voltage / Logic "0" Input Current	1, 2, 3 1, 2 1, 2, 3 1, 2	Full + 25°C/ + 125°C - 55°C Full + 25°C/ + 125°C	2.0		0.8 ±1.0 ±1.0 5.5 ±1.0	0.0		0.8 ±1.0 ±1.0 5.5 ±1.0	ν μΑ ν μΑ	$\begin{array}{c ccccccccccccccccccccccccccccccccccc$
# Logic "0" Input Current		- 55°C	<u> </u>		±1.0			±1.0	μA	
ANALOG OUTPUT # Voltage # Current (Not Short Circuit Protected) # Impedance Capacitive Load (See text) # Noise in Track Mode ³		+25°C +25°C +25°C +25°C +25°C +25°C	± 10 ± 50	0.1 250	1.0	± 10 ± 50	0.1 250	1.0	V mA Ω pF	$\begin{array}{c c} \bullet & \bullet & 0.010 \pm 0.002 \\ \bullet & \bullet & 0.500 \pm 0.010 \\ (15.24 \pm 0.254) \end{array}$
dc to 100kHz dc to 1MHz dc to 5MHz		1250		15 34 0.1			15 34 0.1		μV rms μV rms mV rms	HTC-0300AM and HTC-0300AM/883B
DC ACCURACY/STABILITY # Gain	1 2,3 1 2,3 2,3	+ 25°C + 25°C Full + 25°C Full Full	-1.0	±0.05 ±0.005 ±0.5	±0.1 ±0.01 +5	- 1.0	±0.05 ±0.005 ±0.5	± 0.1 ± 0.15 ± 0.01 ± 0.01 ± 5	V/V % % % ppm FS/°C	ESD SYMBOL ON TOP DENOTES PIN NO. 1
Temperature Coefficient TRACK (SAMPLE) MODE DYNAMICS Frequency Response (V _{IN} = 1V p-p; Pins 11 & 12 = "0") ↓ Small Signal (- 3dB) Full Power (- 3dB) ↓ Slew Rate (V _{IN} = 10V p-p; Pins 11 & 12 = "0")	2,3 4 4 5,6	Full + 25°C + 25°C + 25°C Full	8 220 180	±3	±15	8 220 180	± 3	±15	ppm FSR/°C MHz MHz V/µs V/µs	0.23 (5.84)
 # Harmonic Distortion⁴ TRACK (SAMPLE)-TO-HOLD DYNAMICS # Aperture Time Aperture Uncertainty (Jitter) \/ Pedestal (Offset Step) \/ Pedestal Sensitivity to + 5V Supply Changes Switching Transient \/ Amplitude \/ Settling Time To 0.1% 	4 5,6 4 5,6 7	+ 25°C + 25°C + 25°C + 25°C Full + 25°C + 25°C Full + 25°C Full + 25°C	4	80 6 50 ±2.5 5 180 180 40	8 ± 20 380 380 85	4	80 6 50 ± 2.5 5 180 180 40	8 ± 20 ± 8 380 380 85	dB ns ps, rms mV ppm FS/°C mV/V mV p-p mV p-p ns	0.095 (2.413) 0.095 (2.413) 0.095 (2.667) 0.020 (0.508) 0.090 (2.032) 0.090 (2.032) 0.090 (2.232) 0.090 (2.232)
To 0.1% To 0.01% To 0.01% HOLD MODE DYNAMICS	8 7 8	Full +25°C Full		40 60 60	85 100 100		40 60 60	85 100 100	ns ns ns	PIN DESIGNATIONS
 ✓ Droop Rate ✓ Feedthrough Rejection (V_{IN}=20V p-p@2.5MHz) 	4 5 6 7	+ 25°C + 125°C - 55°C + 25°C	64	±0.5 74	±5	64	±0.5	±5 ±1.8 ±5	μ V/μs mV/μs μV/μs dB	(As viewed from bottom) PIN FUNCTION PIN FUNCTION 24 +15V 1 ANALOG OUTPUT
HOLD (SAMPLE)-TO-TRACK DYNAMICS ↓ Acquisition Time to 0.1% (10V p-p Step) ↓ Acquisition Time to 0.01% (10V p-p Step) Acquisition Time to 0.1% (20V p-p Step)	7 8 7 8	+ 25°C Full + 25°C Full + 25°C		100 100 160 160 110	170 170 200 200		100 100 160 160 110	170 170 200 200	ns ns ns ns ns	23 POWER GROUND 2 N/A 22 -15V 3 N/A 21 GROUND 4 N/A 20 N/A 5 N/A 19 N/A 6 N/A 18 N/A 7 N/A 16 N/A 9 +5V 15 INPUT GROUND 10 LOGIC GROUND 14 N/A 11 HOLD COMMAND 13 ANALOG INPUT 12 HOLD COMMAND

				o + 85°C FC-0300			+ 125°C C-0300A 33B AM/3	м	
Parameter ^{1,2} (Conditions)	Sub- Group	Temp.	Min	Тур	Max	Min	Тур	Max	Units
$\begin{array}{l} \text{POWER REQUIREMENTS} \\ \text{Supply Voltages} \\ \pm V_S \\ V_{CC}(\text{Logic Supply}) \\ \text{Supply Currents}(V_{IN}\!=\!0V; \end{array}$		± 25°C + 25°C	± 14.25 +4.75		± 15.75 + 5.25	± 14.25 + 4.75		± 15.75 + 5.25	v v
$\begin{array}{c} \text{Pins 11 \& 12 = "0")} \\ \checkmark \qquad \pm \text{V}_{\text{S}} \end{array}$	1 2, 3	+ 25°C Full		±21 +21	±25 +25		±21 +21	±25 +25	mA mA
 ✓ V_{CC}(Logic Supply) ✓ Power Dissipation 	1 2,3 1	+25°C Full +25°C		+4 +4 650	+5 +5 775		+4 +4 650	+5 +5 775	mA mA mW
	2,3	Full		650	775		650	775	mW
	1 2, 3	+ 25°C Full		± 0.3 ± 0.3	$\substack{\pm 0.5 \\ \pm 0.5}$		± 0.3 ± 0.3	±0.5 ±0.5	mV/V mV/V
THERMAL RESISTANCE Case to Air, θ_{ca}^{5} Junction to Case, θ_{jc}				34 28			34 28		°C/W °C/W
MEAN TIME BETWEEN FAILURES (MTBF) ⁶						2.1×10 ⁶	,		Hours

NOTES

/100% tested (See Notes 1 and 2).

#Specification guaranteed by design; not tested.

HTC-0300A parameters preceded by a check (/) are tested at +25°C ambient temperature; performance

is guaranteed over the industrial temperature range ($-25^\circ\!C$ to $+85^\circ\!C$) case temperature. 2 HTC-0300AM, ATD/883B, AM/883B parameters preceded by a check (,/) are tested at $-55^\circ\!C$ case,

125°C ambient, and +125°C case temperatures.
Noise level increases with increasing duty cycle of Hold Command. Noise figures shown for Track mode are measured with input grounded and filters for frequencies shown on output $V_{1N} = 20V \text{ p-p}$, 200kHz sine wave; $R_L = 1k\Omega$; Mode Control = Track.

e relationship between the device package and outside environment (θ_{ca}) varies with the application. Value shown is based on measuring case temperature with supply voltages applied to a device installed in a ZIF socket mounted on a standard "EJ" burn-in board.

⁶MTBF calculated for /883B unit using MIL-HNBK 217D; Ground Fixed; Temperature (Ambient) = +25°C. Specifications subject to change without notice

ABSOLUTE MAXIMUM RATINGS

Supply Voltages

$\pm V_S$ $\pm 18V$
$V_{\rm CC}$ 0.5, +7V
Storage Temperature65°C to +150°C
Junction Temperature + 150°C (A & AM)
Junction Temperature
••••••••••••••••••••••••••••••••••••••
Lead Soldering (10sec) + 300°C
Digital Inputs0.5V to Vcc
Analog Input ± 15V

Explanation of Group A Military Subgroups

Subgroup	1 – Static tests at +25°C.
(10% PI	DA calculated against Subgroup 1 for high-rel versions)
Subgroup	2 - Static tests at maximum rated temperature.
Subgroup	3 - Static tests at minimum rated temperature.
Subgroup	4 – Dynamic tests at +25°C.
Subgroup	5 - Dynamic tests at maximum rated temperature.
Subgroup	6 - Dynamic tests at minimum rated temperature.
Subgroup	7 - Functional tests at +25°C.
Subgroup	8 – Functional tests at maximum and minimum rated temperatures.
Subgroup	9 – Switching tests at +25°C.
Subgroup	10 - Switching tests at maximum rated temperatures.
	11 - Switching tests at minimum rated temperatures.
	12 - Periodically sample tested.

TRACK/HOLD FUNCTION TRUTH TABLE

HOLD (Pin 11)	HOLD (Pin 12)	Operating Mode of HTC-0300A is		
0	0	Track		
0	1	Track		
1	0	Hold		
1	1	Track		

APPLICATIONS

Track-and-hold (T/H) amplifiers can be used in a wide variety of ways, but the most common application for these units is to place them ahead of an A/D converter. The combination of a T/H and converter is used when the bandwidth of the signal to be digitized is wider than the converter can handle by itself, i.e., the analog input is changing more than one LSB during the converter's conversion interval.

In applications of this type, the HTC-0300A "freezes" the incoming signal on command to present a nonchanging signal at the input stage of the converter.

The HTC-0300A T/H can reduce the aperture window to 100 picoseconds when used with the appropriate A/D. It can also be used for peak-holding functions, simultaneous sampling A/Ds (when combined with analog multiplexers), and other high-speed analog signal processing applications.

THEORY OF OPERATION

When operated in the "track" mode, the HTC-0300A functions as an operational amplifier with a gain of -1, following all changes in the analog input signal as they occur.

When a TTL-compatible digital logic "1" is applied to the Hold Command input of the T/H, the inverted analog output of the HTC-0300A is "held" at the value which was present at the time of the Hold Command, plus the aperture time. If the change from the "track" mode to the "hold" mode is accomplished via

Pin 11, Hold Command input (Pin 12) must be connected to ground.

For applications which require an inverted Hold Command, this "freezing" of the inverted analog output can be accomplished with a digital "0" applied to the Hold Command (Pin 12) input. In this case, a digital "1" establishes the "track" mode of operation. For these, the Hold Command input (Pin 11) must be connected to +5V.

Refer to Figure 1, the HTC-0300A Track/Hold Waveforms.

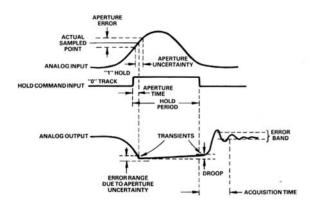


Figure 1. Track/Hold Waveforms - HTC-0300A

Two different intervals of time can affect the point on the analog input which is sampled when the T/H is switched from "track" to "hold". There is no major difference in operation whether this change in state is accomplished via the Hold Command or Hold Command; the functioning of the HTC-0300A is essentially the same, with only a slight difference in timing because of an additional logic package in the Hold Command signal path.

The delay interval, aperture time, is a constant and should not be regarded as an error source. The design of the HTC-0300A assures that aperture time is within its spec from unit to unit; and is also repeatable from one "hold" command to the next in any given unit. In this way, aperture time can be compensated with system timing to assure an optimum sampling point.

Aperture uncertainty, or "jitter", is the other interval affecting the held value. It is the result of noise signals which modulate the phase of the hold command and shows up as sample-to-sample variations in the value of the analog signal being "frozen."

As expected, the error resulting from jitter is directly related to the dV/dt of the analog input. If very-high-speed inputs are sampled, any given value of jitter will result in larger errors in the held value at the output as dV/dt increases. See Figure 2.

The high feedthrough rejection of the HTC-0300A in the hold mode is an important characteristic; it precludes errors being introduced during the conversion interval of the digitizer.

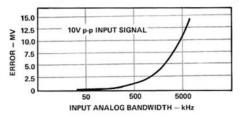


Figure 2. HTC-0300A Error Due to Aperture Uncertainty

As shown in Figure 1, droop is the amount the output changes during the hold period; this is the result of loading on the internal hold capacitor. Low droop rates are important in T/H amplifiers to insure they are appropriate for high-resolution digitizing. Excessive droop rates can negate the effectiveness of having converters of 10 or 12 bits or more. Lower-order bits may be in error because of changes in the held value during the conversion cycle, especially for successive-approximation converters.

The return to the "track" mode is accomplished by changing the digital logic level of the hold command; Figure 1 shows the hold command as it would appear at the (Pin 11) Hold Command input.

Acquisition Time is the interval required for the analog output to re-establish accurate tracking of the changing input and remain within a specified error band around its final value. The greater the change in the input value during the hold period, the longer this interval is. Nyquist sampling is the most stringent application.

Transients shown in Figure 1 are "spikes" which occur at the output of the T/H at the beginning and end of each "hold" period because of switching transients within the unit. When a T/H is used at the output of a D/A converter for "deglitching" discontinuities in the output of the converter, these transients occur at the update rate and can be filtered.

SAMPLE-AND-HOLD (S/H) MODE

Although it is generally used in the track-and-hold mode, the HTC-0300A can also be used as a sample-and-hold device. In the S/H mode, the output of the unit is usually in the "hold" mode, but is switched briefly to the "sample" (track) mode.

The width of the the sample pulse applied to the $\overline{\text{Hold}}$ Command input (or, if using inverted logic, the Hold Command input) is determined by (1) the acquisition time of the HTC-0300A, and (2) the desired accuracy of the sampled output. Output accuracy will also be a function of the amount of change which has occurred since the preceding sample.

This latter phenonmenon is illustrated in Figure 3. Note the analog input has changed drastically between the first and second hold commands. There is a considerably smaller change between the third and fourth pulses; as a consequence, movement in the held value of the output is correspondingly smaller.

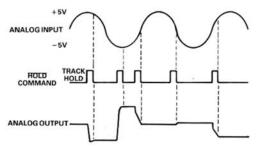


Figure 3. Sample/Hold Operation

Figure 4 illustrates settling accuracy versus acquisition time; closer accuracies require more time. The relationship approaches an asymptotic curve and is not a linear function.

The HTC-0300A is a "closed loop" T/H and is suitable for most applications requiring a track-and-hold for update rates up to 5–10MHz. (Note: 5MHz conversion rates are only a guide and are based on system acquisition time, not logic speed. Higher rates are possible with trade-offs in acquisition time.)

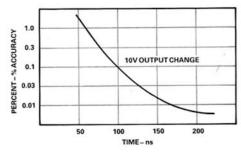


Figure 4. Settling Accuracy vs. Acquisition Time

For optimum performance, the HTC-0300A must have external bypass capacitors connected to the power supply pins close to the device. Electrolytic capacitors of $10 - 22\mu$ F and ceramic capacitors of $0.01 - 0.1\mu$ F on each supply will enhance performance of the unit.

Output loading has some restrictions. To avoid oscillations, limit capacitive loads to 250pF; the recommended resistive loading is 500 Ω . Acquisition and settling times are relatively unaffected by capacitive loads up to 50pF and resistive loads down to 250 Ω .

A massive ground plane, careful component layout, and physically separating digital and analog signals as much as possible are also among the multitude of items which can affect the operation of circuits that include the HTC-0300A T/H.

Cross coupling of analog and digital signals is often a major problem at high frequencies. Relatively low levels of ground plane noise can "mask" lower-order bits when the HTC-0300A is used in high-resolution digitizing. The user must exercise care in electrical and mechanical design to assure satisfactory performance.